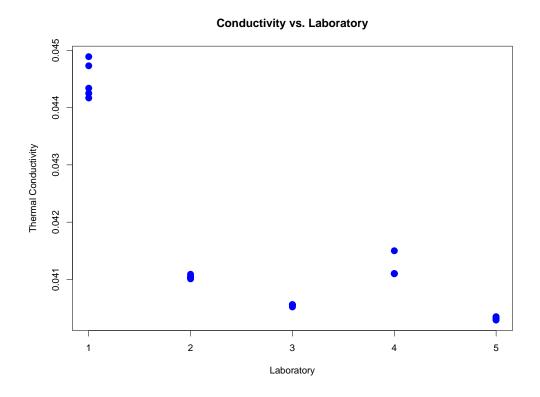
# Bayesian Analysis of a NIST Dataset: Interlaboratory Study on Thermal Conductivity

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## Introduction

- Thermal conductivity measured by 5 labs, with 5 measurements from each lab.
- A Bayesian hierarchical model was fit which allows for both between laboratory variability, and for different within-laboratory measurement uncertainties.
- Results are determined from exact expressions for the posterior distribution by numerical integration.

### **Data**



Note that the variability among the lab means is much greater than the measurement variabilities within labs, and that the different labs have different measurement precisions.

## Hierarchical Model With Noninformative Priors

 $i = 1, \dots, k$  indexes laboratories

 $j = 1, \dots, n_i$  indexes measurements

$$p(x_{ij}|\delta_i, \sigma_i^2) = N(\delta_i, \sigma_i^2)$$

$$p(\sigma_i) \propto 1/\sigma_i$$

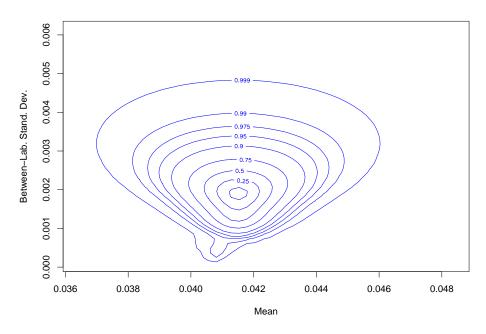
$$p(\delta_i|\mu, \sigma^2) = N(\mu, \sigma^2)$$

$$p(\mu) = 1$$

$$p(\sigma) = 1$$

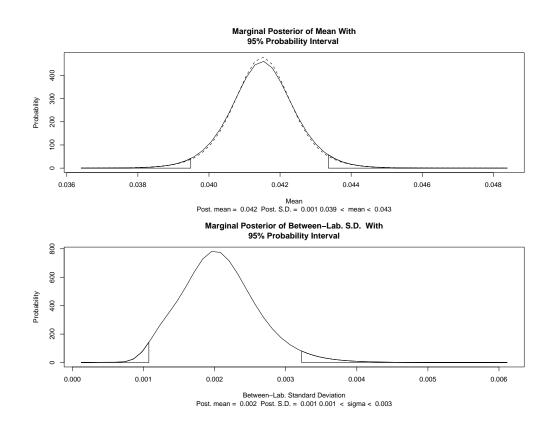
# Joint Posterior Distribution of Overall Mean and Between-Laboratory Standard Deviation

#### **Contours of Marginal Posterior Distribution**



Numbers on indicate the probability that the mean and between-lab standard deviation are both within the corresponding contour. Note that the between-laboratory standard deviation is definitely nonzero, as one would expect.

## Marginal Posterior Distributions for Mean Thermal Conductivity and Between-Laboratory Standard Deviation



These *marginal* distributions were obtained out by integrating out one of the variables in the bivariate distribution displayed previously. The intervals indicated correspond to 95% posterior probability. The broken curve in the top figure indicates t-distribution approximation for posterior mean thermal conductivity.